

**Notice of References Cited**

Application/Control No.

10/578,780

Applicant(s)/Patent Under

Reexamination

TANOUÉ ET AL.

Examiner

Tan V. Mai

Art Unit

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,844,828	12-1998	Fujimura et al.	708/209
*	B US-5,822,231	10-1998	Wong et al.	708/209
C	US-			
D	US-			
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**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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